

IRFP140NPbF

HEXFET® Power MOSFET

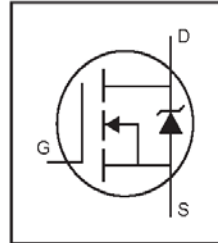
- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated

- Lead-Free

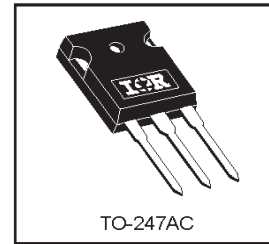
Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole.



| |
|----------------------------|
| $V_{DSS} = 100V$ |
| $R_{DS(on)} = 0.052\Omega$ |
| $I_D = 33A$ |



Absolute Maximum Ratings

| | Parameter | Max. | Units | |
|---------------------------|--|-------------|-------|-----------------------|
| $I_D @ T_C = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$ ⑤ | 33 | A | |
| $I_D @ T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$ ⑤ | 23 | | |
| I_{DM} | Pulsed Drain Current ①⑤ | 110 | | |
| $P_D @ T_C = 25^\circ C$ | Power Dissipation | 140 | W | |
| | Linear Derating Factor | 0.91 | W/°C | |
| V_{GS} | Gate-to-Source Voltage | ± 20 | V | |
| E_{AS} | Single Pulse Avalanche Energy ②⑤ | 300 | mJ | |
| I_{AR} | Avalanche Current① | 16 | A | |
| E_{AR} | Repetitive Avalanche Energy① | 14 | mJ | |
| dv/dt | Peak Diode Recovery dv/dt ③⑤ | 5.0 | V/ns | |
| T_J | Operating Junction and | -55 to +175 | °C | |
| T_{STG} | Storage Temperature Range | | | |
| | Soldering Temperature, for 10 seconds | | | 300 (1.6mm from case) |
| | Mounting torque, 6-32 or M3 screw. | | | 10 lbf•in (1.1N•m) |

Thermal Resistance

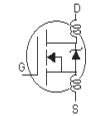
| | Parameter | Min. | Typ. | Max. | Units |
|-----------------|-------------------------------------|------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case | — | — | 1.1 | °C/W |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | — | 0.24 | — | |
| $R_{\theta JA}$ | Junction-to-Ambient | — | — | 40 | |

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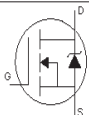
Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|---------------------------------|--------------------------------------|------|------|-------|----------|---|
| $V_{(BR)DSS}$ | Drain-to-Source Breakdown Voltage | 100 | — | — | V | $V_{GS} = 0V, I_D = 250\mu A$ |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient | — | 0.11 | — | V/°C | Reference to 25°C , $I_D = 1mA$ ③ |
| $R_{DS(on)}$ | Static Drain-to-Source On-Resistance | — | — | 0.052 | Ω | $V_{GS} = 10V, I_D = 16A$ ④ |
| $V_{GS(th)}$ | Gate Threshold Voltage | 2.0 | — | 4.0 | V | $V_{DS} = V_{GS}, I_D = 250\mu A$ |
| g_{fs} | Forward Transconductance | 11 | — | — | S | $V_{DS} = 50V, I_D = 16A$ ⑤ |
| I_{DSS} | Drain-to-Source Leakage Current | — | — | 25 | μA | $V_{DS} = 100V, V_{GS} = 0V$ |
| | | — | — | 250 | | $V_{DS} = 80V, V_{GS} = 0V, T_J = 150^\circ\text{C}$ |
| I_{GSS} | Gate-to-Source Forward Leakage | — | — | 100 | nA | $V_{GS} = 20V$ |
| | Gate-to-Source Reverse Leakage | — | — | -100 | | $V_{GS} = -20V$ |
| Q_g | Total Gate Charge | — | — | 94 | nC | $I_D = 16A$ |
| Q_{gs} | Gate-to-Source Charge | — | — | 15 | | $V_{DS} = 80V$ |
| Q_{gd} | Gate-to-Drain ("Miller") Charge | — | — | 43 | | $V_{GS} = 10V$, See Fig. 6 and 13 ④⑤ |
| $t_{d(on)}$ | Turn-On Delay Time | — | 8.2 | — | ns | $V_{DD} = 50V$ |
| t_r | Rise Time | — | 39 | — | | $I_D = 16A$ |
| $t_{d(off)}$ | Turn-Off Delay Time | — | 44 | — | | $R_G = 5.1\Omega$ |
| t_f | Fall Time | — | 33 | — | | $R_D = 3.0\Omega$, See Fig. 10 ④⑤ |
| L_D | Internal Drain Inductance | — | 5.0 | — | nH | Between lead, 6mm (0.25in.) from package and center of die contact |
| L_S | Internal Source Inductance | — | 13 | — | | |
| C_{ISS} | Input Capacitance | — | 1400 | — | pF | $V_{GS} = 0V$ |
| C_{OSS} | Output Capacitance | — | 330 | — | | $V_{DS} = 25V$ |
| C_{RSS} | Reverse Transfer Capacitance | — | 170 | — | | $f = 1.0\text{MHz}$, See Fig. 5⑤ |



Source-Drain Ratings and Characteristics

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|----------|---|------|------|------|---------|---|
| I_S | Continuous Source Current (Body Diode) | — | — | 33 | A | MOSFET symbol showing the integral reverse p-n junction diode. |
| I_{SM} | Pulsed Source Current (Body Diode) ①⑤ | — | — | 110 | | |
| V_{SD} | Diode Forward Voltage | — | — | 1.3 | V | $T_J = 25^\circ\text{C}, I_S = 16A, V_{GS} = 0V$ ④ |
| t_{rr} | Reverse Recovery Time | — | 170 | 250 | ns | $T_J = 25^\circ\text{C}, I_F = 16A$ |
| Q_{rr} | Reverse Recovery Charge | — | 1.1 | 1.6 | μC | $di/dt = 100A/\mu s$ ④⑤ |



Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

② $V_{DD} = 25V$, starting $T_J = 25^\circ\text{C}$, $L = 2.0\text{mH}$
 $R_G = 25\Omega, I_{AS} = 16A$. (See Figure 12)

③ $I_{SD} \leq 16A, di/dt \leq 210A/\mu s, V_{DD} \leq V_{(BR)DSS}, T_J \leq 175^\circ\text{C}$

④ Pulse width $\leq 300\mu s$; duty cycle $\leq 2\%$.

⑤ Uses IRF540N data and test conditions.

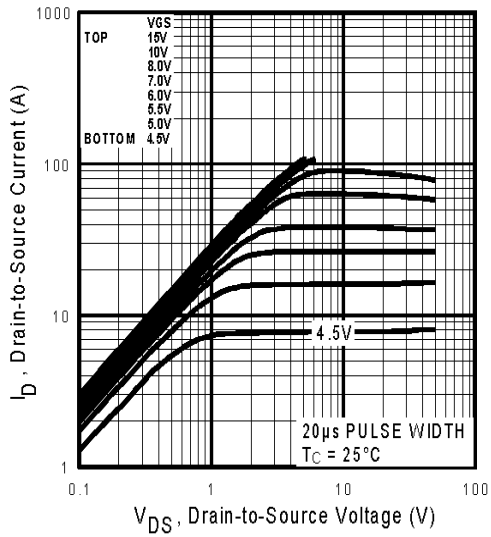


Fig 1. Typical Output Characteristics

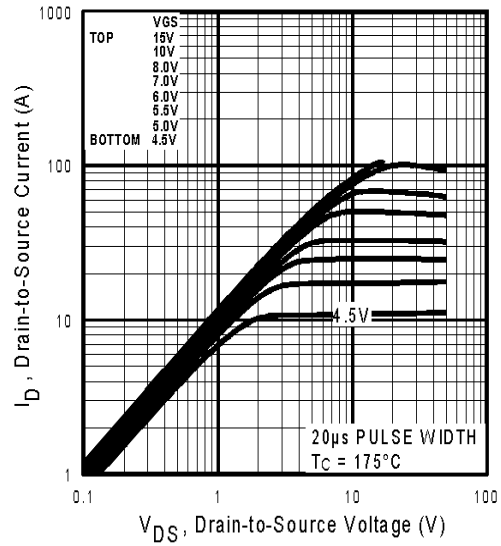


Fig 2. Typical Output Characteristics

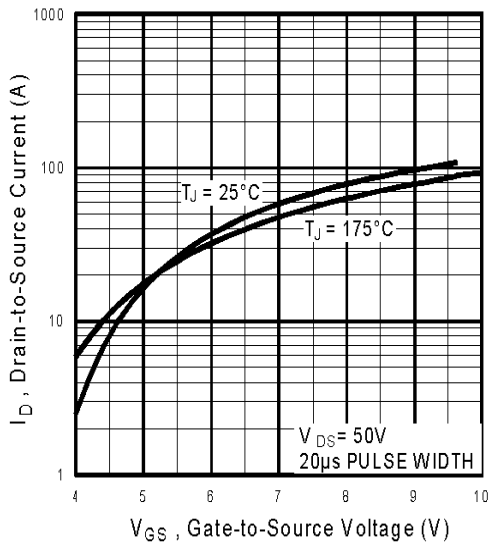


Fig 3. Typical Transfer Characteristics

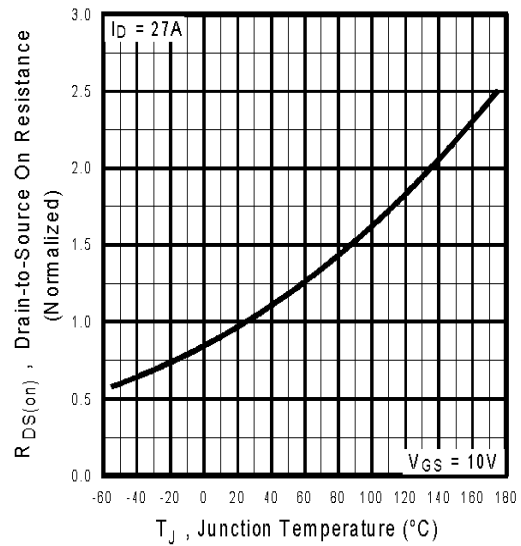


Fig 4. Normalized On-Resistance Vs. Temperature

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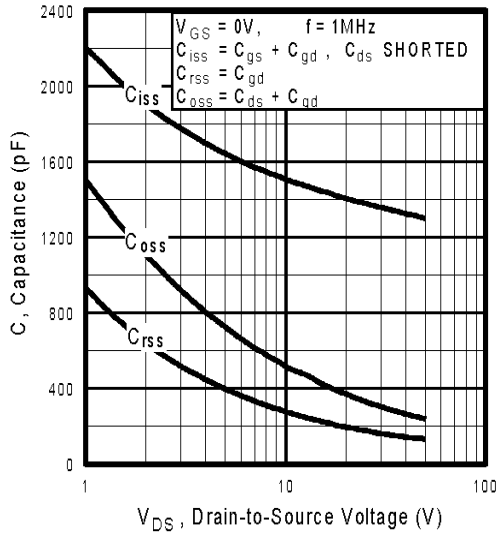


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

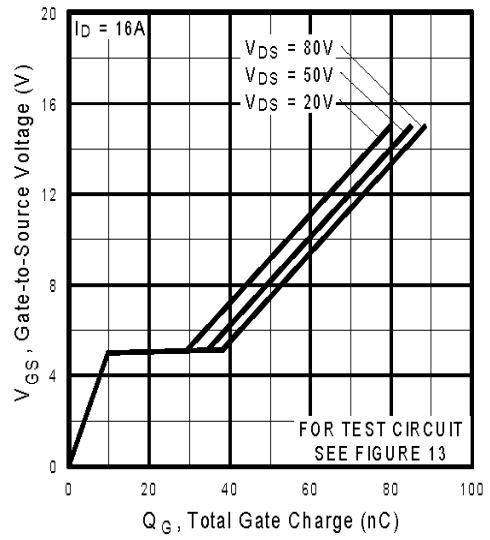


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

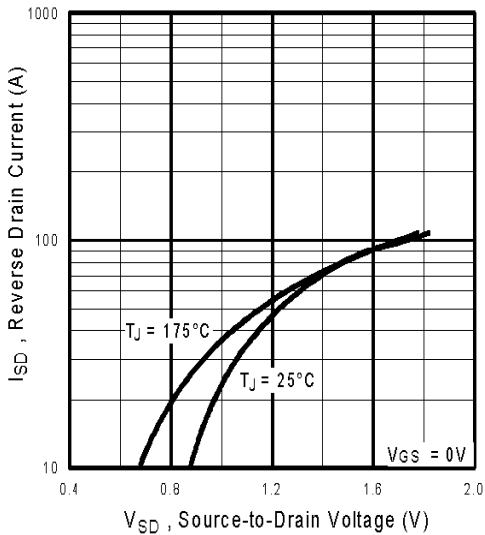


Fig 7. Typical Source-Drain Diode Forward Voltage

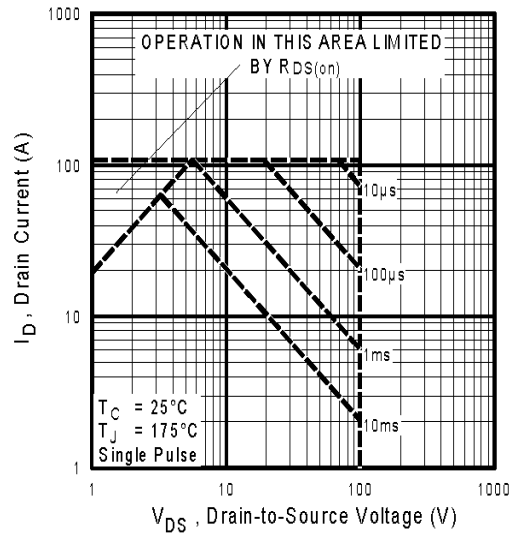


Fig 8. Maximum Safe Operating Area

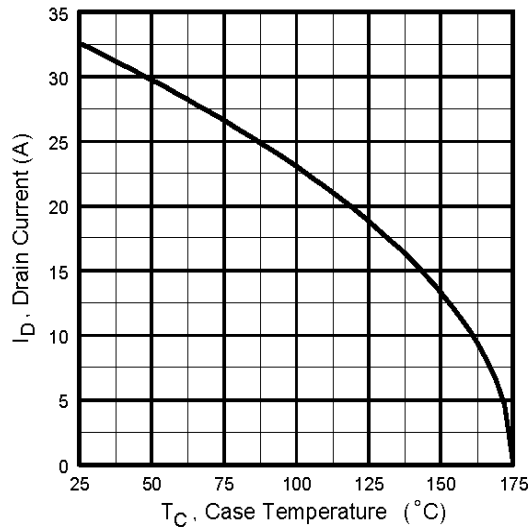


Fig 9. Maximum Drain Current Vs. Case Temperature

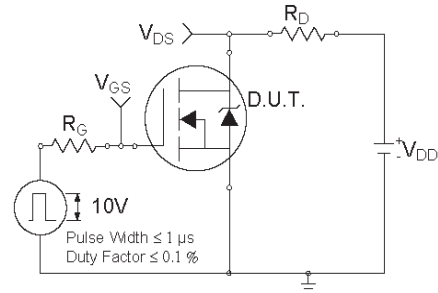


Fig 10a. Switching Time Test Circuit

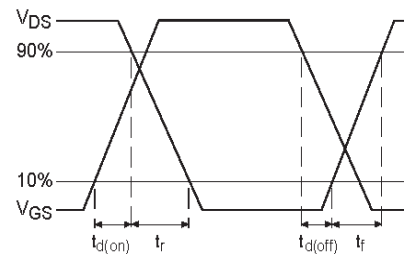


Fig 10b. Switching Time Waveforms

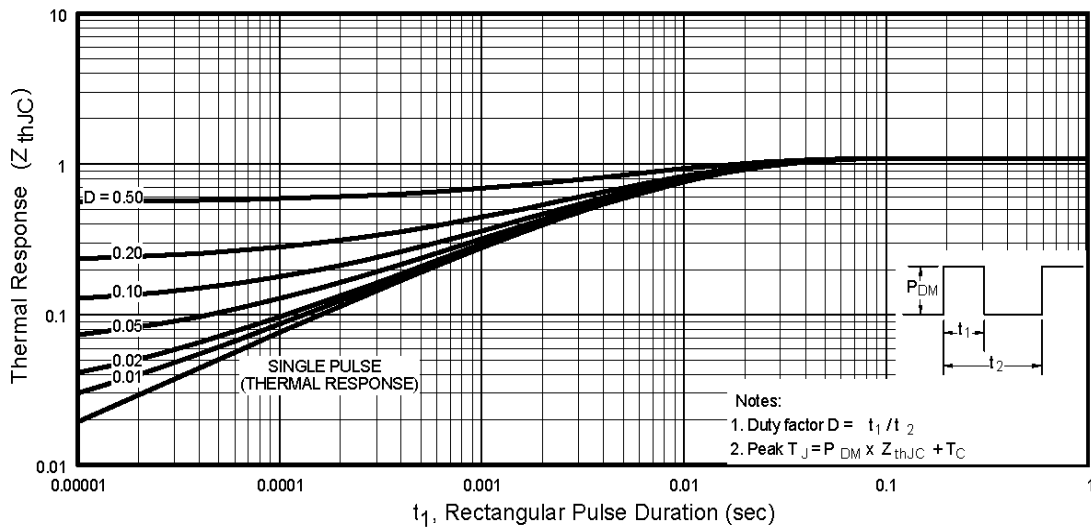


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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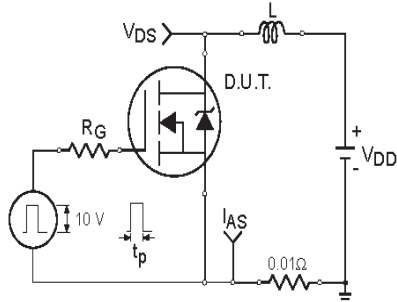


Fig 12a. Unclamped Inductive Test Circuit

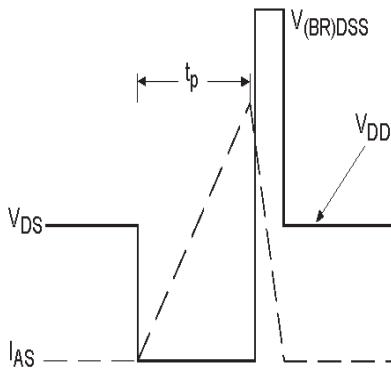


Fig 12b. Unclamped Inductive Waveforms

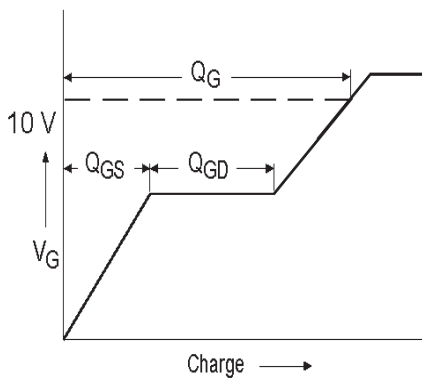


Fig 13a. Basic Gate Charge Waveform

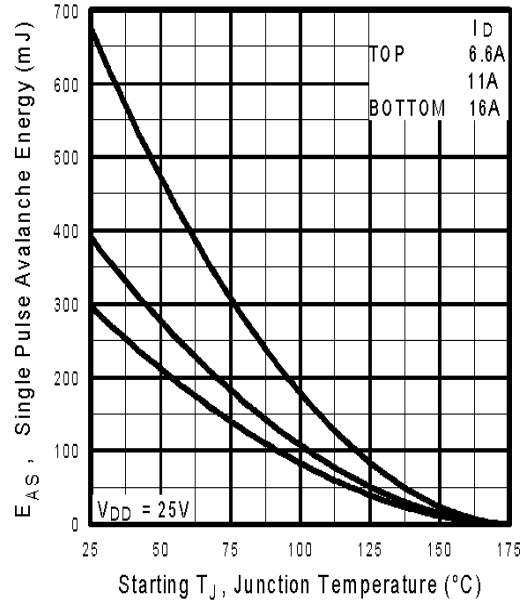


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

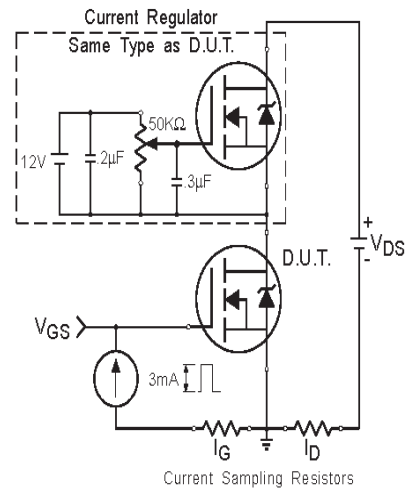
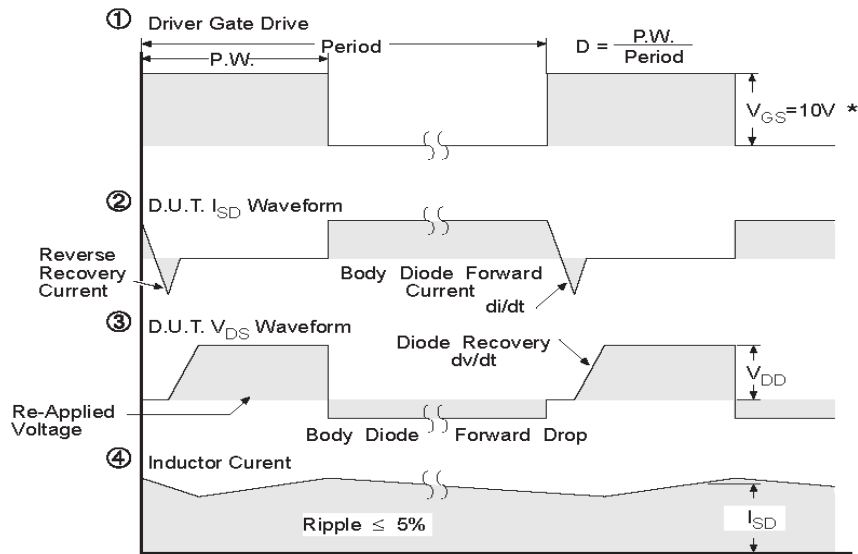
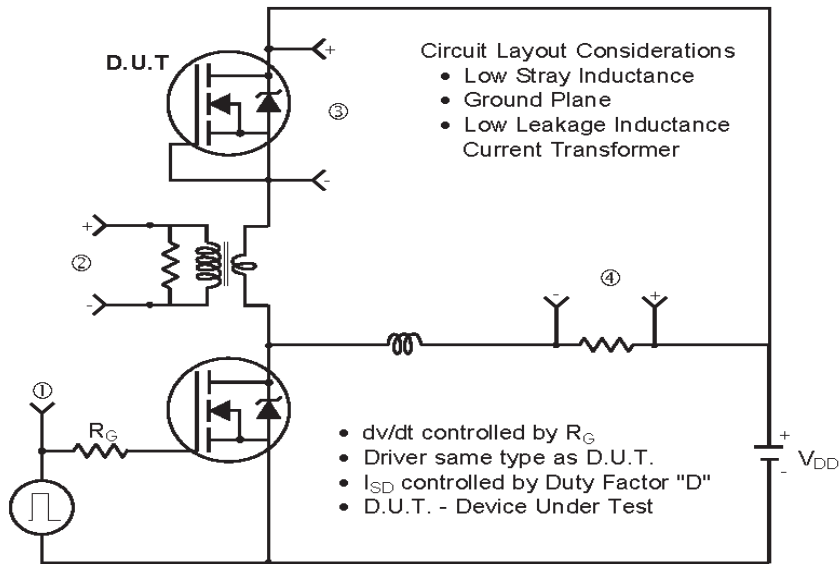


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



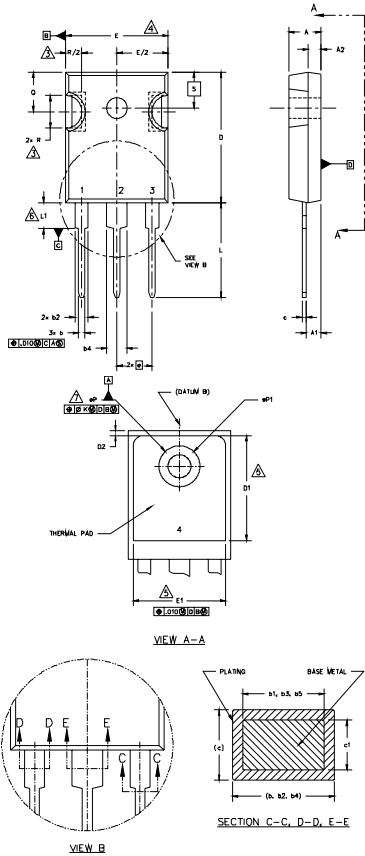
* $V_{GS} = 5V$ for Logic Level Devices

Fig 14. For N-Channel HEXFETS

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TO-247AC Package Outline Dimensions are shown in millimeters (inches)



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M 1994.
- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS]
- CONTOUR OF SLOT OPTIONAL.
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.
- LEAD FINISH UNCONTROLLED IN L1.
- ØP TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5° TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154" [3.91]
- OUTLINE CONFORMS TO JEDEC OUTLINE TO-247 WITH THE EXCEPTION OF DIMENSION c.

| SYMBOL | DIMENSIONS | | | | NOTES |
|--------|------------|------|-------------|-------|-------|
| | INCHES | | MILLIMETERS | | |
| | MIN. | MAX. | MIN. | MAX. | |
| A | .183 | .209 | 4.65 | 5.31 | |
| A1 | .087 | .102 | 2.21 | 2.59 | |
| A2 | .059 | .098 | 1.50 | 2.49 | |
| b | .039 | .065 | 0.99 | 1.40 | |
| b1 | .039 | .053 | 0.99 | 1.35 | |
| b2 | .065 | .094 | 1.65 | 2.39 | |
| b3 | .065 | .092 | 1.65 | 2.37 | |
| b4 | .102 | .135 | 2.59 | 3.43 | |
| b5 | .102 | .133 | 2.59 | 3.38 | |
| c | .015 | .034 | 0.38 | 0.86 | |
| c1 | .015 | .030 | 0.38 | 0.76 | |
| D | .776 | .815 | 19.71 | 20.70 | 4 |
| D1 | .515 | - | 13.08 | - | 5 |
| D2 | .020 | .030 | 0.51 | 0.76 | |
| E | .602 | .625 | 15.29 | 15.87 | 4 |
| E1 | .540 | - | 15.72 | - | |
| e | .215 BSC | | 5.46 BSC | | |
| Øk | .010 | | 2.54 | | |
| L | .559 | .634 | 14.20 | 16.10 | |
| L1 | .146 | .169 | 3.71 | 4.29 | |
| N | 3 | | 7.62 BSC | | |
| ØP | .140 | .144 | 3.56 | 3.66 | |
| ØP1 | - | .275 | - | 6.98 | |
| Q | .209 | .224 | 5.31 | 5.69 | |
| R | .178 | .216 | 4.52 | 5.49 | |
| S | .217 BSC | | 5.51 BSC | | |

LEAD ASSIGNMENTS

HEXFET

- GATE
- DRAIN
- SOURCE
- DRAIN

IGBTs, CoPACK

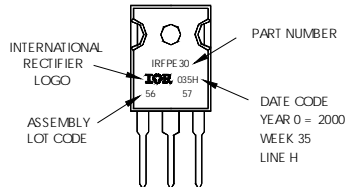
- GATE
- COLLECTOR
- EMITTER
- COLLECTOR

DIODES

- ANODE/OPEN
- CATHODE
- ANODE

TO-247AC Part Marking Information

EXAMPLE: THIS IS AN IRFPE30
WITH ASSEMBLY
LOT CODE 5657
ASSEMBLED ON WW35, 2000
IN THE ASSEMBLY LINE "H"
Note: "P" in assembly line
position indicates "Lead-Free"



Data and specifications subject to change without notice.

International
IR Rectifier

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TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information. 08/04

www.irf.com

Note: For the most current drawings please refer to the IR website at:
<http://www.irf.com/package/>

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